Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/719,807	WEI ET AL.
Examiner	Art Unit
Rai K. Jain	2616

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East, Inventor search.	8/15/2003	RJ	
370/342,343,344,345,335,319,320.	8/15/2003	RJ	
375/130,133,140,141,149.	8/15/2003	RJ	